# **Power MOSFET**

## -30 V, -2.3 A, Dual P-Channel, TSOP-6

### Features

- Fast Switching Speed
- Low Gate Charge
- Low R<sub>DS(on)</sub>
- Independently Connected Devices to Provide Design Flexibility
- This is a Pb–Free Device

### Applications

- Load Switch
- Battery Protection
- Portable Devices Like PDAs, Cellular Phones and Hard Drives

Parameter Symbol Value Unit						
Paramet	Symbol	value	Unit			
Drain-to-Source Voltage	V <sub>DSS</sub>	-30	V			
Gate-to-Source Voltage			$V_{GS}$	±20	V	
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	-2.1	А	
Current (Note 1)	State	$T_A = 85^{\circ}C$		-1.5		
	t ≤ 5 s	T <sub>A</sub> = 25°C		-2.3		
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.1	W	
	t ≤ 5 s			1.3		
Continuous Drain	Steady	$T_A = 25^{\circ}C$	Ι <sub>D</sub>	-1.5	А	
Current (Note 2)	State	$T_A = 85^{\circ}C$		-1.1		
Power Dissipation (Note 2)		$T_A = 25^{\circ}C$	PD	0.6	W	
Pulsed Drain Current	t <sub>p</sub> =	= 10 μs	I <sub>DM</sub>	-10	А	
Operating Junction and Sto	T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C			
Source Current (Body Diode)			۱ <sub>S</sub>	-0.8	А	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C	

### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\thetaJA}$	115	°C/W
Junction-to-Ambient - Steady State (Note 2)		225	
Junction-to-Ambient – t $\leq$ 5 s (Note 1)		95	
Junction-to-Case - Steady State (Note 1)	$R_{\thetaJC}$	40	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. When surface mounted to an FR4 board using 1 in. pad size
- (Cu. area = 1.2 in<sup>2</sup> [1 oz] including traces)

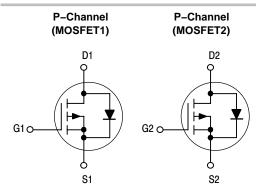
 When surface mounted to an FR4 board using minimum recommended pad size (Cu. area = 0.047 in<sup>2</sup>)

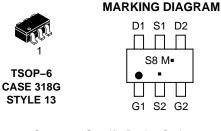


### **ON Semiconductor®**

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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Max
–30 V	160 mΩ @ –10 V
-30 V	280 mΩ @ –4.5 V





S8	= Specific Device Code
Μ	= Date Code*
	= Pb-Free Package

(Note: Microdot may be in either location)

\*Date Code orientation may vary depending upon manufacturing location.

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTGD4161PT1G	TSOP-6 (Pb-Free)	3000 / Tape & Reel

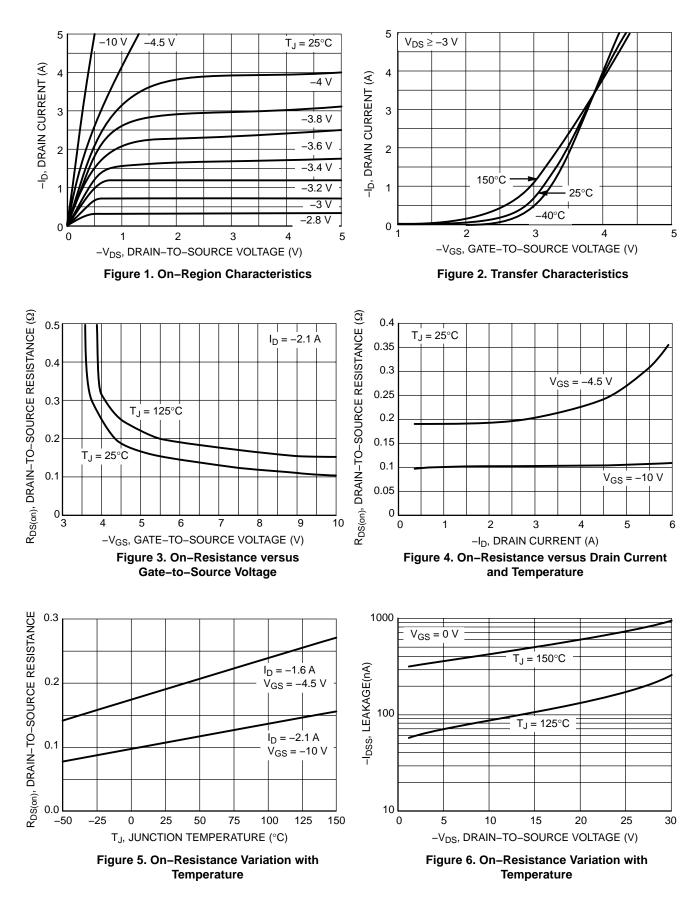
<sup>+</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### ELECTRICAL CHARACTERISTICS (T<sub>J</sub>=25°C unless otherwise stated)

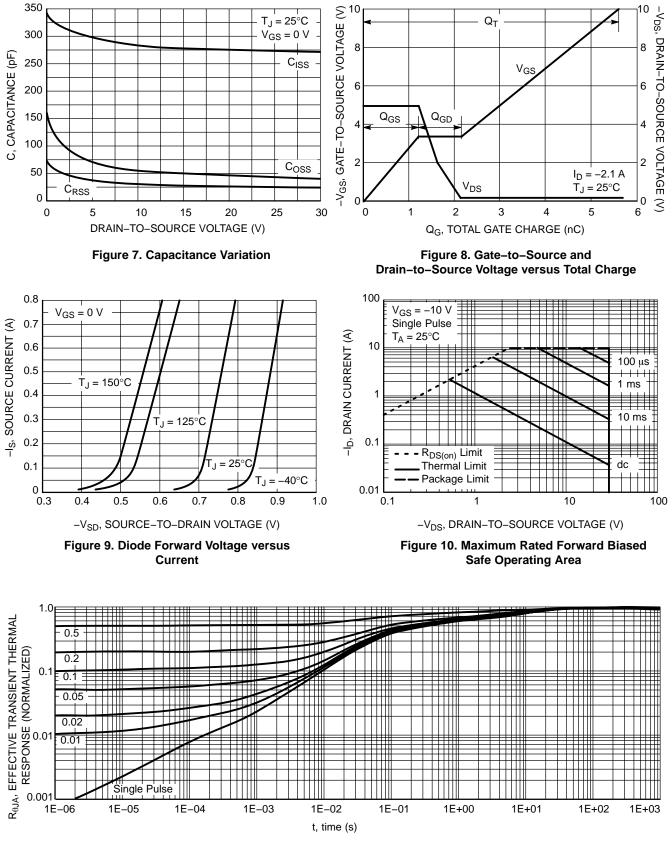
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_D = -250 \mu A$		-30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				22		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			-1.0	μΑ
		$V_{DS} = -24 V$	T <sub>J</sub> = 125°C			-10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>C</sub>	<sub>SS</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							•
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= –250 μA	-1.0	-1.9	-3.0	V
Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-4.7		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10 V, I	l <sub>D</sub> = –2.1 A		105	160	mΩ
		V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -1.6 A			190	280	
Forward Transconductance	9FS	$V_{DS} = -5.0 \text{ V}, \text{ I}_{D} = -2.1 \text{ A}$			2.7		S
CHARGES AND CAPACITANCES			·				
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> = -15 V, f = 1.0 MHz, V <sub>GS</sub> = 0 V			281		pF
Output Capacitance	C <sub>OSS</sub>				50		
Reverse Transfer Capacitance	C <sub>RSS</sub>				28		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = -10 V, V <sub>DS</sub> = -5.0 V, I <sub>D</sub> = -2.1A			5.6	7.1	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.65		
Gate-to-Source Charge	Q <sub>GS</sub>				1.2		
Gate-to-Drain Charge	Q <sub>GD</sub>				0.90		
SWITCHING CHARACTERISTICS (No	ote 4)						•
Turn-On Delay Time	t <sub>d(on)</sub>				7.6	14	ns
Rise Time	tr	V <sub>GS</sub> = -4.5 V, V	י = −15 V.		9.2	23	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_{\rm D} = -1.0$ A, F			12.5	20	7
Fall Time	t <sub>f</sub>				4.5	12	
DRAIN-SOURCE DIODE CHARACTE	RISTICS						•
Forward Diode Voltage	$V_{SD} \qquad V_{GS} = 0 V, \\ I_{S} = -0.8 A \qquad T_{J} = 25^{\circ}C \\ T_{J} = 125^{\circ}C \\ \hline \end{array}$	$V_{GS} = 0 V_{c}$	$T_J = 25^{\circ}C$		-0.79	-1.2	V
			-0.65				
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_S/dt = 100 \text{ A}/\mu\text{s},$ $I_S = -0.8 \text{ A}$			8.0		
Charge Time	ta				5.7		ns
Discharge Time	t <sub>b</sub>				2.3		
Reverse Recovery Charge	Q <sub>RR</sub>				3		nC

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

### **TYPICAL PERFORMANCE CURVES**



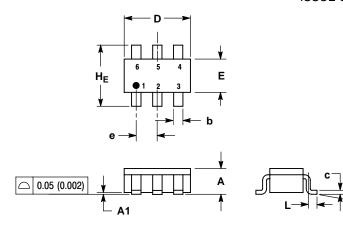
### **TYPICAL PERFORMANCE CURVES**





#### PACKAGE DIMENSIONS

TSOP-6 CASE 318G-02 **ISSUE S** 



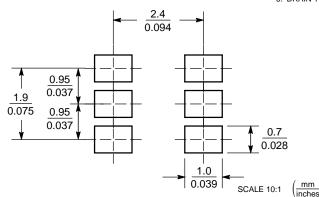
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER 2 MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF 3
- BASE MATERIAL. DIMENSIONS A AND B DO NOT INCLUDE 4 MOLD FLASH, PROTRUSIONS, OR GATE BURRS

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.90	1.00	1.10	0.035	0.039	0.043	
A1	0.01	0.06	0.10	0.001	0.002	0.004	
b	0.25	0.38	0.50	0.010	0.014	0.020	
С	0.10	0.18	0.26	0.004	0.007	0.010	
D	2.90	3.00	3.10	0.114	0.118	0.122	
E	1.30	1.50	1.70	0.051	0.059	0.067	
е	0.85	0.95	1.05	0.034	0.037	0.041	
L	0.20	0.40	0.60	0.008	0.016	0.024	
HE	2.50	2.75	3.00	0.099	0.108	0.118	
θ	0°	-	10°	0°	-	10°	



#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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